Fast Spectral BRDF & BTDF Measurements for Characterization of Displays and Components

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SUMMARY In the present paper we show how to obtain rapidly the spectral BRDF and BTDF of different display components or transparent displays using Fourier optics system under different illumination configurations. Results can be used to simulate the entire structure of a LCD display or to predict transparent display performances under various illuminations.

key words: BRDF, BTDF, multispectral, diffuser, BEF, transparent display

1. Introduction

Emissive properties of LCD displays have significantly improved these last years due to many efforts spend at all the levels of the manufacturing. The improvement of the films used inside the LCD structure can be noticed [1]. To go further and meet the new needs like auto-stereoscopic 3D, future structures will become more and more complex and realistic computer simulations will become mandatory. LED lighting applications are also using many different types of films whose specifications become critical [2]. Simulations using theoretical reflective and transmission properties do not lead generally to realistic results. Consequently, it becomes necessary to measure accurately the optical properties of all the optical components, including light diffusion and scattering, as a function of angles but also wavelengths. Measurement of simple optical components can be made using standard spectrophotometers or reflectometers. Obtaining realistic results in the simulation of complex films producing diffusion or diffraction requires measuring the transmittance and the reflectance as a function of angle with a high resolution and not only in specular configuration.

On the other hand, transparent displays are just in their starting phase with many developments and improvements of the performances [3]. Characterization of transparent displays has not been much studied up to now. Blurring due to diffusion inside the display structure has been measured by imaging luminance meter [4]. Transmittance and reflective properties of transparent displays have also been measured on axis but the angular behavior has not been investigated [5]. Here also the characterization of such displays must be made versus angle and wavelength with a high angular resolution.

Standard gonio-spectrophotometers generally used to measure BRDF and BTDF can be extremely time consuming when medium angular resolution is required. The aim of this paper is to introduce multispectral Fourier optics viewing angle instruments applied to accurate and rapid measurements of the reflection and transmission properties of display components or transparent displays with high angular resolution. This technique has first been introduced for the viewing angle measurement of displays by ELDIM in 1993 [6]. A theoretical comparison of the different viewing angle measurement techniques has been published in 2009 [7]. Standard goniometers and hemisphere base imagers [8] were also investigated. The main drawback of the last technique is clearly the parasitic light that prohibits any high dynamic measurement. More recently, for BRDF measurements, techniques using different types of mirrors in different configurations has been proposed in the literature [9]–[12]. Davis [9], [10] has patented a device using an ellipsoidal mirror to collect the reflected light using a CCD sensor, but the change of incidence for the illumination beam is not easy and spectral measurements are not possible. Dana [11] has constructed a system using a paraboloid mirror that has comparable problems. Mukaigawa [12] presents another system including an ellipsoidal mirror and a projector were the incidence beam can be changed easily but the use of a camera allows only color measurements. For all these mirror based techniques the major problem lays always in the parasitic light that cannot be suppressed completely and prohibits any high dynamic range measurements which are required for glossy samples. Rarely mentioned but very important is the tradeoff always existing between the angular resolution and the measurement spot size. Indeed the angular resolution is driven by the size of the mirror and the resolution of the camera. It is maximal only when the spot size is zero due to simple geometric considerations. In practice, glossy sample measurements are not possible except using very large instruments.

In the following, experimental details on the multispectral Fourier optics measurement system and on the way to measure spectral BRDF and BTDF under full diffuse or collimated beam illumination are reported in the first part. Measurements on various display components and on a transparent LCD display are discussed in a second part to illustrate the different measurement modes and the capability of the method.

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2. Experimental Techniques

2.1 Viewing Angle Measurements

The measurement system is based on a Fourier optic which is designed to convert all the angular field map into a planar one (cf. Fig. 1 (a)). Compared to standard goniometers, the main interest of this kind of system is to allow full viewing angle map recording in only one measurement. Each light beam emitted from the sample surface is collected by the optics and refocused on a Fourier plane at a position proportional to the incidence and azimuth angles. This Fourier plane is reimaged on a CCD detector. In between the first Fourier plane and the detector there is a position that is in proportional to the incidence and azimuth angles. This Fourier optics and refocused on a Fourier plane at a position proportional to the size of illumination on the sample surface. One iris located at this position defines the normal incidence spot size on the sample (cf. Fig. 1). So, the angular aperture and resolution and the spot size are defined independently in this very specific optical setup avoiding the tradeoff mentioned above for mirror based systems. Another main interest of the optical setup is the light collection efficiency even at high angles since the spot size is increasing with the angle (in $1/\cos^2\theta$ like for a standard goniometer). The correspondence between pixels and angles is calibrated using a reference goniometer with a collimated source.

The multispectral viewing angle system EZContrastMS based on Fourier optics has been introduced in 2008 to measure the spectral emission of displays [13]. The system measures the full viewing angle up to 88° versus wavelength thanks to 31 band-pass filters regularly distributed in the visible range (every 10 nm). One spectral measurement needs 31 images and the angular resolution is excellent (around 0.2° for the EZContrastMS system with 880 × 880 pixels angular images). This system is also capable to measure the polarization state and was used to characterize polarization 3D displays [14].

2.2 BRDF Measurements

For reflective measurements, it is necessary to illuminate the sample. EZContrastMS system offers this possibility using a beam splitter and an additional optics that allows illumination at any angle easily and accurately (cf. Fig. 1 (a)) [15]. The white light is injected on the illumination Fourier plane using a small optical fiber. Because of the optical setup, the size of the fiber defines the divergence of the illumination beam independently of the size of illumination spot on the sample. For the BRDF measurements, a 50 μm optical fiber is used that gives a divergence lower than 0.3° on the sample surface. The system has been used to measure different type of surfaces and e-papers [15], and to evaluate the outdoor properties of displays [16]. This system is also capable to illuminate and to measure exactly at the same angle allowing backscattering investigation of cosmetic foundations for example [17].

Full characterization of the reflective properties of a surface requires measurements at different incidence angles if the surface is isotropic. In the anisotropic case, different incidence and azimuth angles have to be measured. For each incidence beam the spectral BRDF is given by:

$$BRDF(\theta, \varphi, \theta_i, \varphi_i, \lambda) = \frac{dL_r(\theta, \varphi, \theta_i, \varphi_i, \lambda)}{dE_i(\theta, \varphi, \lambda)}$$

where ($\theta_i, \varphi_i$) and ($\theta, \varphi$) are the polar coordinates of the incidence light beam and detection direction respectively. The radiance $dL_r(\theta, \varphi, \theta_i, \varphi_i, \lambda)$ diffused by the surface is directly measured by the instrument.

The irradiance of the sample $dE_i(\theta, \varphi, \lambda)$ is obtained using a further measurement of one Spectralon sample using the same illumination conditions. Spectralon, a registered trademark of Labsphere Inc. is a fluoropolymer with high diffuse reflectance generally used as a reference standard for calibration of spectrophotometers. The irradiance is given by the Eq. (2):

$$dE_i(\theta, \varphi, \lambda) = \int_{2\pi} R_s(\theta, \lambda)L_W(\theta, \varphi, \theta_i, \varphi_i, \lambda) \cos(\theta_i) d\Omega_f$$

$L_W(\theta, \varphi, \theta_i, \varphi_i, \lambda)$ is the radiance measured on the spectralon sample and $R_s(\theta, \lambda)$ the reflectance coefficient of the spectralon. In Eq. (2) the light is integrated on the total angular aperture of the instrument. On the contrary of conventional goniometer systems, the Fourier optics instrument allows calibrating correctly the illumination without assuming that Spectralon surface is perfectly Lambertian. Different BRDF measurements made with variable incidence angles on a Spectralon surface are reported in Fig. 2. In agreement with previous studies [18], the surface becomes quite specular at high incidence angles.

2.3 BTDF Measurements

BTDF measurements require illumination across the sam-
ple with a collimated beam at an adjustable incidence and azimuth. This can be obtained using the BTDF option that includes a two-axis goniometer and a collimated and stabilized white LED source (cf. Fig. 3). The software allows automatic correction from the misalignment between the viewing-angle system and the goniometer axis. Automatic measurements versus incidence and azimuth angles can be performed. The BTDF and BRDF options make it possible to measure the spectral BRDF and spectral BTDF of any optical component at all incidence and azimuth angles with an excellent angular resolution in reasonable measurement times.

3. Characterization of Backlight Components

3.1 Structure & Components

In the following we present results obtained on diffusion layers and brightness enhancement film (BEF) involved in a simple backlight as shown in Fig. 4.

3.2 Full Diffuse Transmittance of the Backlight

The full diffusion transmittance of the backlight structure is reported in Fig. 5. It is measured using a near Lambertian lamp and gives an overall idea of the properties of the full system. The effect of light refocus near normal incidence of the BEF film is seen clearly but this type of measurement
does not give information on the behavior of each light beam crossing the structure. In this respect, BTDF measurements using collimated beam at different incidences and azimuths are required.

3.3 BTDF of the Diffuser Plates

Diffuser plates that are made from transparent resin usually contain some fine particles known as light diffuser agents in order to obtain sufficient diffusivity. This diffusivity largely depends on the difference in refractive index between the particle and the matrix, and on the diameter of the light diffuser agent. A first approach of the diffusing properties can be obtained using Mie scattering theory. However, since the density of diffusing particles is high, the effect of multiple scattering must be considered. Moreover the distribution of size must be also taken into account. Therefore, accurately predicting the light scattering characteristics for simple object like diffuser plates is quite difficult and measurement are mandatory to take into account correctly their diffusing properties.

We have measured the spectral BTDF of the two diffusing plates (diffuser 2 and 3 in Fig. 4) at various incident angles. Diffusion pattern obtained at 537 nm on the diffuser plate 2 for an incidence angle of 30° is reported in Fig. 6 (a). Horizontal cross sections for various incident angles are also reported in Fig. 6 (b). We can observe two very well defined haze components for the angles below 40° and only one above 40°. The sharpest haze component related to the transmitted peak is reduced by the increase of thickness to cross when increasing the angle. The comparison with diffuser plate 3 is reported in Fig. 7. The main difference is in the amplitude of the transmitted peak probably due to a different thickness of the diffuser plate.

3.4 BTDF of BEF Film

BEF are prismatic films that manage the angular output of light from the backlight. They use refraction to compress the backlight output towards an on-axis viewer as schematically reported in Fig. 8. If the incidence is far from on axis, the light beam is refracted inside the prismatic struc-
ture and reoriented near normal incidence or recycled inside the backlight.

It is easy to express the angle of the transmitted beam in the plane perpendicular to the prismatic structure. If \( \theta_i \) is the incidence angle, \( \alpha \) the prism angle and \( N \) the optical index of the film, we can write the Eqs. (3), (4) and (5):

\[
\sin \theta_i = N \sin \theta_r \quad (3)
\]

\[
N \sin(\alpha - \theta_r) = \sin \theta_f \quad (4)
\]

\[
\theta_e = \alpha - \theta_f \quad (5)
\]

They can be used to predict the angular position of the transmitted beam across the BEF film (6) as schematically represented in Fig. 8:

\[
\theta_e = \alpha - \sin^{-1} \left[ N \sin(\alpha - \sin^{-1} \left( \frac{\sin \theta_i}{N} \right)) \right] \quad (6)
\]

We have measured several BTDF patterns at various incidence angles in the plane perpendicular to the prisms (azimuth 0°). Combination of several BTDF patterns measured at 609 nm are reported in Fig. 9 (a). The incidence angle of the measured transmitted beam is compared to its theoretical values computed for an optical index value \( N = 1.53 \) and a prism angle of 44.5° are reported in Fig. 9 (b). The haze around each transmitted beam is due to the imperfections of the prismatic structure (roughness and slope distribution) and cannot be predicted theoretically.

For BTDF measurements outside of the plane perpendicular to the prism, the light behavior is more complex. Measurements obtained with incident beams in the plane at 45° or along the prisms are reported in Figs. 10 (a) and 10 (b) respectively. At 45°, the diffusion remains limited. Along the prism edges, the diffusion plays the key role as shown in Fig. 10 (b).

### 4. Characterization of Transparent LCD Display

Results reported in this part have been obtained on a One ODHitec transparent LCD. This model OD121S1LG-TAS is a 12.1” display with 800 × 600 resolution which is generally used in show cases and indoor applications.
4.1 Full Diffuse Spectral Transmittance

We have measured the full diffuse transmittance of the white, black, red, green and blue states (W, K, R, G, B) of the display. The transmission coefficients measured at normal incidence versus wavelength are reported in Fig. 11. The transmission coefficient of the black state is two orders of magnitude lower than the others meaning we can for example neglect the contribution of R and G switched of pixels in the blue transmittance. The transmission coefficients are
in line with the announced specifications: there are in the range 6-10% for the different sub-pixels.

The angular dependence of the white state is reported in Fig. 12. Interference fringes can be detected in the angular pattern at 630 nm (cf. Fig. 12 (a)) and versus wavelength in the red region (cf. Fig. 12 (b)). The black state is quite good with very low transmittance at all the wavelengths for incidence angles lower than 40°.

Using the spectral transmittance data the performances of the display can be computed for any type of illuminant used as backlight for the display. Simulation of white and black states using a 100 cd/m² D65 illuminant are reported in Fig. 13. In spite of a limited luminance of the white state (due to a low white transmittance), the luminance contrast is comparable to standard LCD displays. The simulated color patterns for red, green and blue states are reported in Figs. 14 (a), 14 (b) and 14 (c) respectively. Parasitic light along horizontal and vertical directions for incidence angles higher than 40° appear clearly. Finally, the color gamut behavior can be deduced (cf. Fig. 14 (d)).

4.2 Full Diffuse Spectral Reflectance

To measure full diffuse reflectance the sample is illuminated across the Fourier optics system with an integration sphere whose exit is located at the illumination Fourier plane (cf. Fig. 1 (a)). A light trap is positioned on the other side of the transparent display in order to avoid external parasitic reflections. The reflection pattern reported in Fig. 15 (a) is characteristic of an air/glass interface reflection with some additional modulations due to the liquid crystal cell. This small modulation depends on the state of the transparent display but differences between white and black states do not exceed few percents.

4.3 Collimated Beam Spectral BTDF

Since the display is intended to be transparent for the viewer, its diffusion must be minimized otherwise the image seen across will be blurred. Therefore measurements under collimated beam are useful. Light diffraction has already been observed on such displays [10], but a high resolution angular
measurement has not been made. We have made such a measurement on our display. The diffraction pattern obtained at 669 nm is reported in Fig. 16 (a). The complexity of the pattern results certainly of the geometry of the transparent and not transparent structure of the display. The diffusion contribution is always less than 0.1% of the incoming light beam but extends in all the angular aperture up to 88° as shown in the horizontal cross sections reported in Fig. 16 (b).

4.4 Collimated Beam Spectral BRDF

One example of collimated beam BRDF measurement for white state at 630 nm is reported in Fig. 17 (a). In addition to the specular contribution, diffusion patterns are clearly visible along two particular directions. The amplitude of the diffusion is small with regards to the specular reflection but can be seen easily if the display is illuminated with a bright punctual source. One way to understand the origin of this diffusion is to report the same data in the BRDF space (cf. Fig. 17 (b)). The diffusion takes place now along horizontal and vertical showing that the diffusion is probably due to some diffraction inside the LCD structure and along the horizontal and vertical alignments of pixels of the display. This type of phenomenon can be also observed on OLED displays and generally with a higher amplitude [21].

5. Conclusions

In the literature, the characterization of the optical components of LCD displays or LED lighting systems is generally made under full diffusion illumination. An overall characteristic of the component is obtained but those data cannot be used in a ray tracing software. On the contrary, real BRDF and BTDF data can be introduced easily in such software. Concerning BEF films it is possible to simulate the basic on axis compression effect with a perfect model like discussed in Ref. [22], but the introduction of imperfections is mandatory to obtain a realistic simulation. The use of spectral BTDF measurements can make more realistic ray tracing simulations taking into account only one light beam at a time. The ultimate purpose of such work is to provide ray tracing software using real accurate experimental spectral BRDF and BTDF data in order to simulate complex stacks efficiently.

A transparent LCD display has also been optically characterized in details. Full diffuse transmittance measurements allow to predict the color and luminance of the display under any full diffuse illumination and the main characteristics of the display can be deduced for all the angular aperture. Luminance contrast and color gamut behavior of the studied display are closed to those of a standard LCD display. The overall transmittance of the display is quite low due to the liquid crystal cell and the polarizers. Since the display is intended to allow the observer to see objects across it, the light diffusion should be quite limited. We have validated it using a collimated beam illumination across the display. Some diffraction is nevertheless occurring that extend over the entire viewing angle but the light level is below 0.1% of the specular contribution.

Parasitic reflection contributions have also been evaluated using full diffuse and collimated beam illuminations. The reflection properties are driven by the top interface air/glass with a small modulation of the crystal cell. Diffraction in reflection mode is also occurring but only along the horizontal and vertical directions and with a low level comparable to what was observed in transmission mode.

References


